

30V N-Channel Enhancement-Mode MOSFET

● APPLICATIONS

- 1)Advanced trench process technology
- 2)High Density Cell Design For Ultra Low On-Resistance
- 3)We declare that the material of product compliant with RoHS requirements and Halogen Free.

● FEATURES

- 1) $V_{DS} = 30V$
- 2) $R_{DS(ON)}, V_{GS}@10V, I_{DS}@5.8A = 38m\Omega$
- 3) $R_{DS(ON)}, V_{GS}@4.5V, I_{DS}@5.0A = 43m\Omega$
- 4) $R_{DS(ON)}, V_{GS}@2.5V, I_{DS}@4.0A = 62m\Omega$

● DEVICE MARKING AND ORDERING INFORMATION

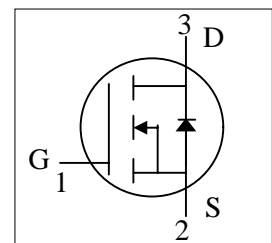
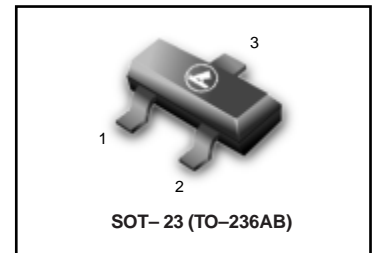
Device	Marking	Shipping
LN2306LT1G	N06	3000/Tape&Reel
LN2306LT3G	N06	10000/Tape&Reel

● MAXIMUM RATINGS($T_a = 25^\circ C$)

Parameter	Symbol	Limits	Unit
Drain-to-Source Voltage	V_{DSS}	30	V
Gate-to-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current	I_D	5.8	A
Pulsed Drain Current (Note1)	I_{DM}	30	A
Maximum Power Dissipation	P_D	1.4	W
Operating and Storage Temperature Range	T_J, T_{stg}	-55 to +150	$^\circ C$
Junction to Ambient Thermal Resistance(PCB mounted)(Note 2)	$R_{\theta JA}$	140	$^\circ C/W$

1. Repetitive Rating: Pulse width limited by the Maximum junction temperature
2. 1-in² 2oz Cu PCB board

LN2306LT1G



LN2306LT1G
● ELECTRICAL CHARACTERISTICS (Ta= 25°C)
STATIC

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Drain-to-Source Breakdown Voltage	V(BR)DSS	30	–	–	V	VGS = 0 V, ID = 250 μA
Gate Threshold Voltage	VGS(TH)	0.7	–	1.4	V	VGS = VDS, ID = 250 μA
Zero Gate Voltage Drain Current	IDSS	–	–	-1	μA	VDS=24V, VGS=0V
Gate-to-Source Leakage Current	IGSS	–	–	±100	nA	VDS = 0 V, VGS = ±12 V
Drain-to-Source On Resistance	RDS(on)	–	31	38	mΩ	VGS = 10 V, ID =5.8 A
		–	34	43		VGS = 4.5 V, ID =5 A
		–	45	62		VGS = 2.5 V, ID = 4 A
Forward Diode Voltage	VSD			1.2	V	VGS = 0 V, ISD = -1A
Forward Transconductance	gFS	10	15	–	S	VDS = 5.0 V, ID = 5 A

DYNAMIC(Note 3)

Input Capacitance	Ciss	–	513.51	–	pF	VGS = 0 V, f = 1.0 MHz, VDS= 15 V
Output Capacitance	Coss	–	80.85	–		
Reverse Transfer Capacitance	Crss	–	54.87	–		
Total Gate Charge	QG	–	11.00	14.3	nC	VGS =4.5 V, VDS = 15 V ID = 5.8 A
Gate-to-Source Gate Charge	QGS	–	1.60	2.08		
Gate-to-Drain Charge	QGD	–	2.80	3.64		
Turn-On Delay Time	td(on)	–	7.00	14	ns	VDD = 15V, RL = 2.7 Ω ID = 1A, VGEN = 10V RG = 3 Ω
Rise Time	tr	–	15.00	30		
Turn-Off Delay Time	td(off)	–	38.00	76		
Fall Time	tf	–	3.00	6		

3.Pulse test: pulse width ≅ 300us, duty cycle ≅ 2%

LN2306LT1G

ELECTRICAL CHARACTERISTIC CURVES

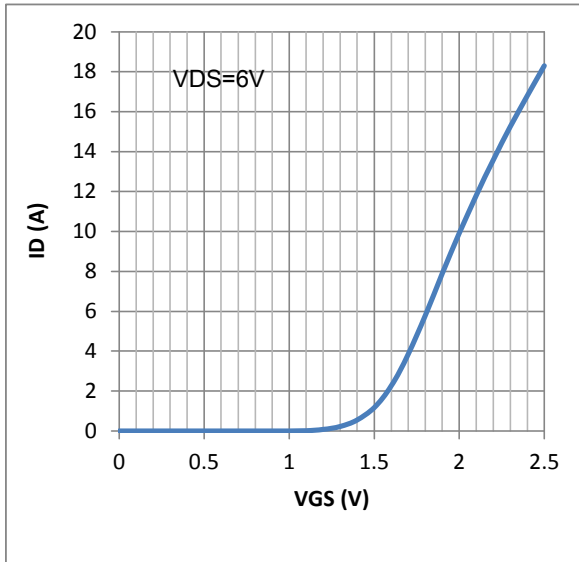


FIG.1 Transfer Characteristics

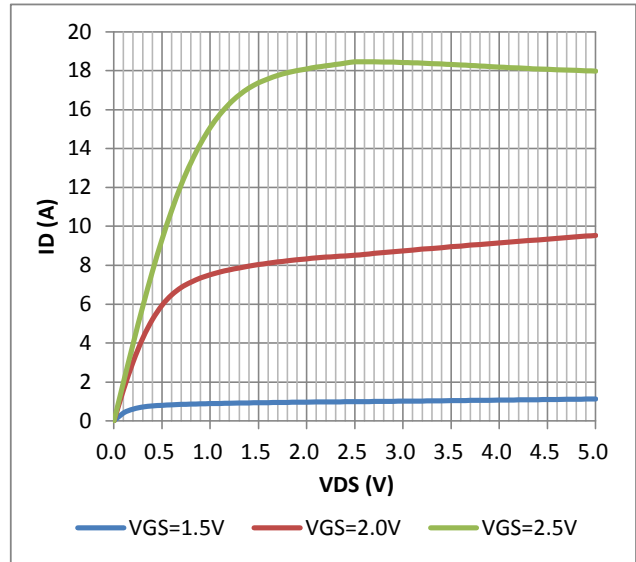


FIG.2 On-Region Characteristics

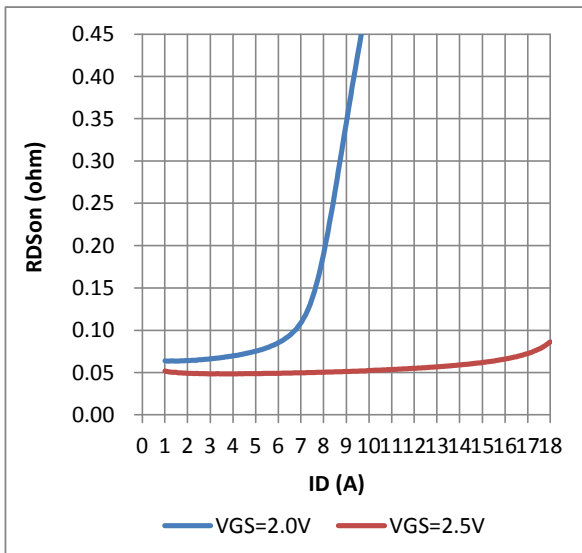


FIG.3 On-Resistance vs. Drain Current

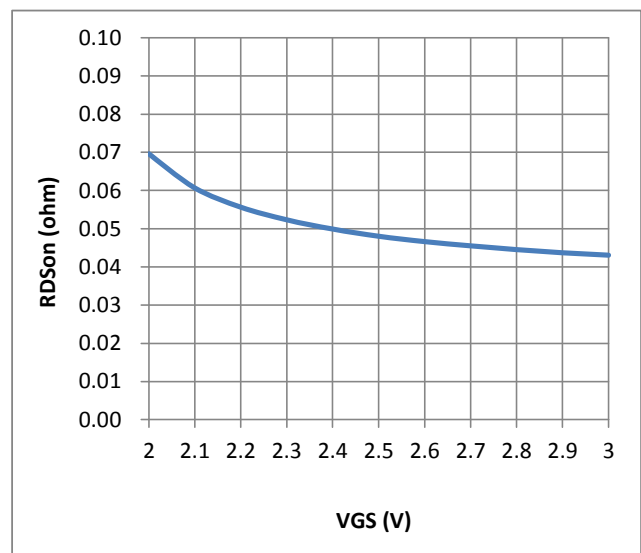


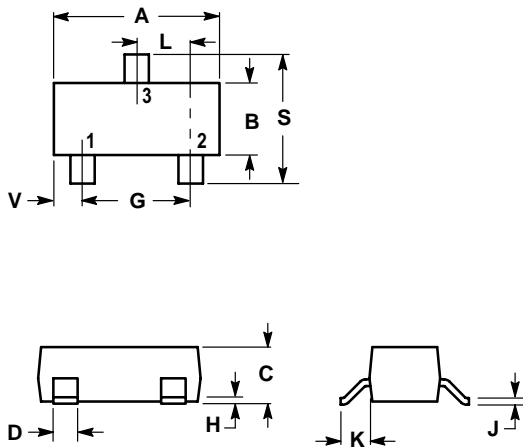
FIG.4 On-Resistance vs. Gate-to-Source Voltage

LN2306LT1G

SOT-23

NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M,1982
2. CONTROLLING DIMENSION: INCH.



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.1102	0.1197	2.80	3.04
B	0.0472	0.0551	1.20	1.40
C	0.0350	0.0440	0.89	1.11
D	0.0150	0.0200	0.37	0.50
G	0.0701	0.0807	1.78	2.04
H	0.0005	0.0040	0.013	0.100
J	0.0034	0.0070	0.085	0.177
K	0.0140	0.0285	0.35	0.69
L	0.0350	0.0401	0.89	1.02
S	0.0830	0.1039	2.10	2.64
V	0.0177	0.0236	0.45	0.60

